



UNITED STATES PATENT AND TRADEMARK OFFICE

Commissioner for Patents  
United States Patent and Trademark Office  
Washington, D.C. 20231  
www.uspto.gov  
DNW 09-01

Paper No. 10

HAVERSTOCK & OWENS LLP  
SUITE 420  
260 SHERIDAN AVENUE  
PALO ALTO , CA 94306

**COPY MAILED**

**OCT 01 2001**

**OFFICE OF PETITIONS**

In re Application of :  
Harmon, Butts, Battaile, Heilman, :  
Caglar, Marchala, Carner, and Varma: DECISION REFUSING STATUS  
Application No. 09/637,984 : UNDER 37 CFR 1.47(a)  
Filed: 11 August, 2000 :  
Attorney Docket No. SYNOPSIS-007

This is in response to the renewed petition under 37 CFR 1.47(a),  
filed on 19 September, 2001 (certificate of mailing date 12  
September, 2001).

The petition is again dismissed.

Rule 47 applicant is given TWO MONTHS from the mailing date of  
this decision to respond, correcting the below-noted  
deficiencies. Any response should be entitled "Request for  
Reconsideration of Petition Under 37 CFR 1.47(a)" and may include  
an oath or declaration executed by the inventor. **Failure to  
respond will result in abandonment of the application.** Any  
extensions of time will be governed by 37 CFR 1.136(a).

Petitioners state that the non-signing inventor, Raju Marchala,  
has now signed the declaration, and that the executed declaration  
was filed with the renewed petition. A review of the official  
file reveals, however, that no signed declaration is located  
among the papers filed on 19 September, 2001. The signed  
declaration should be submitted with a renewed petition.

Further correspondence with respect to this matter should be  
addressed as follows:

By mail: Assistant Commissioner for Patents  
Box DAC  
Washington, D.C. 20231

By FAX: (703) 308-6916  
Attn: Office of Petitions

By hand: Crystal Plaza Four, Suite 3C23  
2201 S. Clark Place  
Arlington, VA

Telephone inquiries concerning this matter may be directed to the undersigned at (703)308-6918.



Douglas I. Wood  
Petitions Attorney  
Office of Petitions  
Office of the Deputy Commissioner  
for Patent Examination Policy